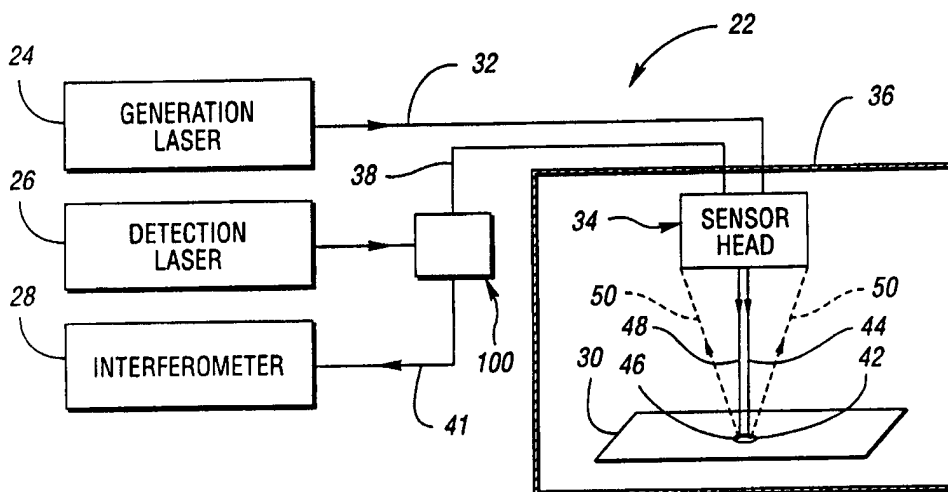




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(54) Title: METHOD AND SYSTEM FOR PROCESSING MEASUREMENT SIGNALS TO OBTAIN A VALUE FOR A PHYSICAL PARAMETER



(57) Abstract

A method and system are disclosed for processing time-varying measurement signals (28) to obtain a value for a physical parameter by extracting frequency information from the signals (28). The frequency information includes at least one desired frequency. The frequency information is converted to a value for the physical parameter. Extraction is performed by transforming discrete time ultrasonic signals to a Z-domain (182) and converting at least one zero or pole in the Z-domain to the desired frequency and its decay rate. The measurement signals may be coherent light signals (24, 26, 28) which are frequency modulated based on the propagation of longitudinal waves in the object. For a static film, the physical parameter may be thickness of a cured layer. When the object is a dynamic curable film, its thickness changes over time from an initial value, to an intermediate value, and to a final value.

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METHOD AND SYSTEM FOR PROCESSING MEASUREMENT SIGNALS TO OBTAIN A VALUE FOR A PHYSICAL PARAMETER

Technical Field

5 This invention relates to methods and systems
for processing measurement signals to obtain a value for
a physical parameter and, in particular, to methods and
systems for processing measurement signals to obtain a
value for a physical parameter of an object wherein the
10 measurement signals are obtained by measuring time-
varying physical signals containing frequency informa-
tion related to the physical parameter of the object.

Background Art

15 In any coating process of an article of
manufacture such as an automotive body, there is an
optimum specification for the resulting film build,
i.e., thickness of the resulting coating layer involving
acceptable performance, appearance and materials cost.
The ability to measure this film build on-line in a
20 production environment would be beneficial to the
manufacturer.

Often, any method for measuring the film build
of a coating layer must require that no contact with the
film occur either to avoid degrading the effectiveness
25 or marring the appearance of the film. This is espe-
cially true for coatings while they are wet.

With manufacturing film build data, the bulk
materials costs can be controlled by applying the

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minimum amount of material to reach an acceptable film build. Other savings can also be realized, for example measuring and improving the transfer efficiency of the coating process and correlating film build to the quality of the appearance of the final coated surface. An example process and production environment that would benefit from the ability to measure film build on-line is the painting of automobile bodies.

In automated painting operations, a prime concern is the reduction of environmental impacts due to the evaporation of solvents. Means of reducing the amount of solvent released into the atmosphere include electrostatic application of the paint and the use of waterborne paints. Electrostatic application increases the quantity of paint delivered to the painted object, and thus reduces the total quantity of paint required due to the decrease in overspray. The use of waterborne paints dramatically reduces the quantity of solvent utilized in the paint because water is used as a vehicle for paint delivery rather than solvent. Environmental concerns may dictate the exclusive use of waterborne paints in the future.

In order to further reduce waste, thus reducing solvent emissions, and to improve the quality of the finished painted article, it may be necessary to monitor or sense various paint physical parameters such as thickness with precision to effect control.

Waterborne paints are electrically conductive and, therefore, must be isolated from the environment such that an electrostatic charge may be imparted to the flow of paint. This isolation must be at least 100

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kiloVolts. Further, the painting environment is a hazardous environment due to the few remaining solvents in the paint. Therefore, any device which meters or measures the physical parameters of paint must provide
5 electrostatic isolation and limit energies within the painting environment to less than that required for ignition.

The painting process for automobiles involves applying several coatings of different materials to an
10 underlying metal or plastic substrate 10. As illustrated in Figure 1, these coatings may include various anti-corrosion layers such as a phosphate layer 12, an E-coat layer 14, primer layer(s) 16, colored paint layers 18 (referred to as base coats), and a transparent protec-
15 tive and appearance improving material(s) called a clearcoat 20. The ability to measure both total film build, i.e., the total thickness of all layers, of the thickness of each individual layer, in both the wet or dry states would be useful.

20 One non-contact method for measuring solid film thickness and/or other physical properties of the film is provided by ultrasound generation in the film and subsequent ultrasound detection. However, this method typically locally damages or destroys the film.

25 For example, U.S. Patent No. 4,659,224 discloses optical interferometric reception of ultrasound energy using a confocal Fabry-Perot interferometer and the detection of the Doppler shift of the laser line frequency as the method to detect the ultrasound.

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U.S. Patent No. 5,137,361 discloses optical detection of a surface motion of an object using a stabilized interferometric cavity. The interferometer cavity is stabilized by controlling the position of the rear cavity mirror with a piezoelectric pusher.

U.S. Patent No. 5,402,235 discloses imaging of ultrasonic-surface motion by optical multiplexing. Ultrasound is detected using an array of detectors and a "demodulator". The demodulator is typically a photo-refractive crystal within which a hologram of the laser beam, both directly from the laser and reflected off the sample's surface, are simultaneously written. The interference between sample laser beam and the beam reflected off the sample surface takes place between the two holographic images generated within the crystal.

U.S. Patent No. 5,590,090 discloses an ultrasonic detector using vertical cavity surface emitting lasers. The method requires contact between the sample and the equipment.

U.S. Patent No. 5,035,144 discloses frequency broadband measurement of the characteristics of acoustic waves. Propagating acoustic waves are detected by two different broadband receivers at first and second locations separated by a distance L . The data analysis for this method involves detailed comparisons between group and phase velocities of the data using different amplifiers and narrow band filtering of the signal.

U.S. Patent No. 5,604,592 discloses a laser ultrasonics-based material analysis system and method using matched filter processing. The system uses a

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diode laser for detection. Generation and detection of ultrasound is done at different points. The system relies on Time of Flight (TOF) detection which requires generation and detection at separate points since the basis of the measurement is the time it takes for the ultrasonic energy to travel between the two points. The waveshape of the time varying ultrasonic signal is acquired with a matched filter, processed and basically compared to a library of similar signals.

U.S. Patent No. 5,615,675 discloses a method and system for 3-D acoustic microscopy using short pulse excitation and a 3-D acoustic microscope for use therein.

U.S. Patent No. 5,305,239 discloses ultrasonic non-destructive evaluation of thin specimens. The method involves data analysis for thin specimens, where "thin" is defined as less than or equal to the wavelength of the inspecting acoustic wave. Analysis is demonstrated with a Fast Fourier Transform (FFT). An important aspect of an FFT is that it can only produce discrete frequency results determined by the number of points taken and data rate used.

Summary Of The Invention

An object of the present invention is to provide a method and system for quickly processing measurement signals to obtain a value for a physical parameter in a measurement system in which time-varying physical signals containing frequency information related to the physical parameter of an object are measured to obtain the measurement signals.

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Another object of the present invention is to provide a method and system for processing measurement signals to obtain a value for a physical parameter in a measurement system in which time-varying physical signals containing frequency information related to the physical parameter of an object are measured to obtain the measurement signals, wherein a simple procedure need be performed to measure the physical parameter and wherein no environmental calibration procedure need be performed.

Still another object of the present invention is to provide a method and system for processing measurement signals to obtain a value for a physical parameter in a measurement system in which time-varying physical signals containing frequency information related to the physical parameter of an object are measured to obtain the measurement signals. The physical parameter may be thickness, acoustic impedance, signal transit time, density, speed of sound, attenuation or viscosity of the object which may be a static or dynamic film layer formed on a substrate layer.

Yet, still another object of the present invention is to provide a non-calibrating method and system for processing measurement signals to obtain a value for a physical parameter in a measurement system in which time-varying physical signals containing frequency information related to the physical parameter of an object are measured to obtain the measurement signals. The physical parameter may change in value over time from an initial value to a final value. The frequency information is related to propagation of waves in the object and the frequency information is processed

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with a model of the propagation of the waves in the object.

In carrying out the above objects and other objects of the present invention in a measurement system wherein time-varying physical signals containing frequency information related to a physical parameter of an object are measured to obtain corresponding time-varying measurement signals, a method is provided for processing the measurement signals to obtain a value for the physical parameter. The method includes the step of extracting the frequency information from the measurement signals. The frequency information includes at least one desired frequency. The method also includes the step of converting the frequency information to a value for the physical parameter.

Further in carrying out the above objects and other objects of the present invention in a measurement system wherein time-varying physical signals containing frequency information related to a physical parameter of an object are measured to obtain corresponding time-varying measurement signals, a system is provided for processing the measurement signals to obtain a value for the physical parameter. The system includes means for extracting the frequency information from the measurement signals. The frequency information includes at least one desired frequency. The system also includes means for converting the frequency information to a value for the physical parameter.

Preferably, the frequency information includes a decay rate and an amplitude for the at least one desired frequency.

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The object may be a static film which is a cured layer formed on a substrate. The physical parameter may be thickness of the layer.

5 The object may be a dynamic film having a physical parameter which changes in value over time. The dynamic film may be a wet or dehydrated layer formed on a substrate wherein the physical parameter is thickness of the layer.

10 The physical signals may be electromagnetic signals such as coherent light signals wherein the coherent light signals are modulated coherent light signals and wherein the modulated coherent light signals are modulated based on the frequency information.

15 Where the physical parameter changes in value over time from an initial value to a final value, the step of converting includes the step of predicting the final value from the initial value.

20 Where the physical parameter changes in value over time from the initial value to an intermediate value and then to the final value, the step of predicting includes the step of first predicting the intermediate value from the initial value and then predicting the final value from the intermediate value.

25 The object may be a curable film and the physical parameter may be film thickness and wherein the initial value is wet film thickness, the intermediate value is uncured film thickness and the final value is cured film thickness.

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The frequency information may be related to propagation of waves in the object where the step of predicting includes the step of processing the frequency information with a model of the propagation of the waves
5 in the object.

The measurement signals are preferably discrete-time signals wherein the step of extracting includes the step of transforming the discrete-time signals to a Z-domain and wherein the frequency information is contained in at least one zero or pole in the Z-domain.
10

Preferably, the frequency information includes an amplitude and a decay rate for the at least one frequency wherein the step of extracting further includes the step of converting at least one zero or pole in the Z-domain to the at least one frequency and its decay rate.
15

In the disclosed embodiment, the measurement signals are ultrasonic electrical signals wherein the frequency information is related to propagation of longitudinal ultrasonic waves in the object.
20

The above objects and other objects, features, and advantages of the present invention are readily apparent from the following detailed description of the best mode for carrying out the invention when taken in connection with the accompanying drawings.
25

Brief Description Of The Drawings

FIGURE 1 is a schematic view illustrating a typical automotive coating profile;

5 FIGURE 2 is a schematic view of a simplified measuring system with a two-fiber laser launch system of Figure 5 and constructed in accordance with the present invention;

10 FIGURE 3 is a schematic view of a three-fiber sensor head constructed in accordance with the present invention without its housing;

FIGURE 4 is a schematic view of a two-fiber sensor head constructed in accordance with the present invention;

15 FIGURE 5 is a schematic view of a two-fiber laser launch system constructed in accordance with the present invention and utilized in Figure 2;

20 FIGURE 6 is a schematic view of a more complex system constructed in accordance with the present invention with generation and detection lasers and an interferometer of the system located in a laser room remote from an automotive paint booth in which sensor heads of the system are located;

25 FIGURE 7 is a schematic side elevational view of an automotive vehicle body carried by a conveyor and a portion of a sensor arch having sensor heads constructed in accordance with the present invention;

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FIGURE 8 is a schematic top plan view of a plurality of sensor arches positioned at various locations within a paint booth;

5 FIGURE 9 is a graph illustrating a laser ultrasonic signal obtained from measuring a wet green paint on a 1.0 mil E-Coat with a 1.6 mil primer;

10 FIGURE 10 is a graph of the signal of Figure 9 after transformed by a discrete Fourier transform and which illustrates resonance frequencies of the substrate and a paint film;

FIGURE 11 is a set of graphs, each one of which is similar to the graph of Figure 10 and illustrating how paint peak resonant frequencies change with varying wet paint thickness;

15 FIGURE 12 is a graph illustrating how a calibration curve could be generated from LU measured values of a wet white solvent base coat; and

20 FIGURE 13 is a schematic block diagram flow chart illustrating a processing method and system which focuses on how raw ultrasonic signals and/or data are analyzed.

Best Mode For Carrying Out The Invention

25 Referring now to Figure 2, there is illustrated a schematic view of a simplified system constructed in accordance with the present invention, generally indicated at 22. The system includes a generation laser 24, a detection laser 26, and an interferometer 28.

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The generation laser 24 produces a very short pulse (~10 ns) that is used to generate the ultrasound in a thin liquid or solid film such as paint formed on the article 30. The generation laser 24 is preferably a Nd:YAG laser with an added fixed OPO having a 1570 nm wavelength which provides <10 mJ/pulse at the measured article. The absorption of this laser's light pulse energy causes a temperature rise in the film (certainly <5°C, probably less than 1°C) which, in turn, produces an essentially instantaneously generated density gradient in the material. This density gradient produces ultrasound. (This type of ultrasound generation is referred to as thermoelastic generation.) Thus, the short laser pulse is analogous to a quick hammer strike to a bell thereby generating sound.

For wet films, a second method of ultrasound generation is also present. The energy in the pulsed laser 24 is very small, considerably too small to affect the solid materials in the paint, however it will cause an extremely small portion of solvent (μL) on the film surface to be quickly evaporated. The movement of this solvent mass away from the film produces a force in the opposite direction (i.e., into the film) which is very efficient at generating ultrasound. This ultrasound generation method is referred to as ablative generation, which typically damages the surface of the article inspected. The energies used for this invention will only ablate volatile liquids, not solids, thus no damage occurs to the solid film material.

The detection laser 26 is preferably a Nd:YAG laser having a 1064 or 532 nm wavelength, >2 MHz line-width and provides ≤ 500 mW of power at the article

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inspected. The laser 26 is a nominally continuous (wave, or CW) laser which is used to detect the minute motions (<1 nm) of the sample surface due to the ultrasound. The laser 26 can be thought of as producing a
5 very long pulse especially when compared to the length of the pulse produced by the laser 24.

The laser 26 has a very narrow linewidth and thus it is possible to record the ultrasonic surface motions by monitoring the laser frequency as it is
10 Doppler shifted by the ultrasonic motions. The resulting detection laser light pulse reflected off the article 30 is coupled into the interferometer 28 via an optical fiber 41. The interferometer 28 strips away and records the modulations in this laser light pulse line
15 frequency. The frequency of the film resonance is directly related to its thickness, with a thicker film having a slower resonance, again like a bell.

The interferometer 28 is preferably a confocal Fabry-Perot type interferometer constructed generally in
20 accordance with the teachings of the above-noted Patent No. 5,137,361.

The system 22 also includes a first optical fiber 32 for transmitting the first pulse generated by the generation laser 24 therethrough to a sensor head,
25 generally indicated at 34, which is shown positioned within a spray booth 36 in which the article 30 is located.

The system 22 also includes a second optical fiber 38 for transmitting a second light pulse generated
30 by the detection laser 26 therethrough after striking a

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reflective element or prism 107 in a system 100 as illustrated in Figure 5 which directs the second light pulse into the optical fiber 38.

5 In general, the sensor head 34 directs the first light pulse appearing on the optical fiber 32 at a sensing station within the paint booth 36 toward a first spot 42 along light signal path 44 on a surface of the film of the article 30 to generate an ultrasonic wave such as a longitudinal ultrasonic wave in the film
10 which, in turn, causes ultrasonic motion of the surface of the film without damaging the film or the rest of the article 30.

In general, the sensor head 34 also directs the second pulse of light transmitted through the second
15 optical fiber 38 at the sensing station toward a second spot 46 which is coincident and overlaps the first spot 42 along a light signal path 48 to obtain a reflected pulse of light which returns to the sensor head 34 along a path back to the sensor head. The limits of such a
20 path are indicated at 50 in Figure 2. The reflected pulse of light is modulated based on the ultrasonic motion of the surface of the film, as is well known in the art.

Referring to Figures 2 and 5, the sensor head
25 34 transmits the reflected pulse of light from the sensing station to the optical fiber 38 and then out of the fiber toward a lens 112 of Figure 5. This light is coupled into the fiber 41 by the lens 112 therethrough so that it is received by the interferometer 28 along
30 the optical fiber 41. The interferometer 28 detects the reflected pulse of light to obtain a corresponding

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ultrasonic electrical signal such as the one illustrated in Figure 9.

A three-fiber system may be used instead of the two-fiber system of Figure 2 to eliminate the block 100. However, an extra fiber is needed as illustrated at 76 in Figure 3.

As illustrated in the embodiment of Figure 6, the interferometer 28 is coupled to a computer 50 to process the ultrasonic electrical signal provided by the interferometer 28 to obtain a physical property signal such as a thickness signal which represents the thickness of the film or substrate of the multilayer article 30. In general, the computer 50 is programmed to initially digitize the ultrasonic electrical signal to obtain a discrete-time signal and then, by applying a Z-transform thereto, to obtain the resonance frequencies in the ultrasonic signal. The resonant frequencies obtained from the ultrasonic signal in Figure 9 are illustrated in Figure 10. These frequencies in Figure 10 were obtained by a Fourier transform as opposed to a Z-transform for this illustrative example due only to the ease of graphing the output of a Fourier transform. The actual method to extract the resonant frequencies is with a Z-transform and then the computer 50 processes the resonance frequencies to obtain the thickness signal as described in greater detail hereinbelow.

Referring now to Figure 3, there is illustrated one embodiment of a sensor head, generally indicated at 52 and constructed in accordance with the present invention. The sensor head 52 typically includes a support housing (which housing is not shown in Figure 3

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for simplicity). The sensor head 52 receives the first pulse of light from a coupler 54 formed on one end of the fiber 32 to provide an optical signal 56 which is transmitted through a dichroic beam splitter 58.

5 The sensor head 52 also supports a coupler 60 which couples the optical fiber 38 to the sensor head 52 to transmit a laser light signal 62 to the beam splitter 58 which reflects the second pulse of light. A lens 64 focuses the first and second pulses of light to a prism
10 or mirror 66 which, in turn, reflects the first and second pulses of light along light signal path 68 to the spots 42 and 46 on the article 30. Thus, the first and second pulses of light are directed toward the article collinearly.

15 The resulting reflected pulse of light travels along any path within the limits set by path 70 to a lens 72 which, in turn, focuses the reflected pulse of light to a coupler 74. The coupler 74 is coupled to a collection fiber 76 which returns the reflected pulse of
20 light to the interferometer 28 thereby eliminating the necessity of having the system 100.

Referring now to Figure 4, there is illustrated a second embodiment of a sensor head, generally indicated at 78. The sensor head 78 may be utilized in
25 the system 22 since optical fiber 38 serves not only as a delivery fiber but also as a collection fiber.

The sensor head 78 includes a housing 80 for housing optical components of the sensor head therein. A typical standoff between the housing 80 and the
30 article 30 is 150 mm but can be widely varied. The

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sensor head 78 includes a dichroic beam splitter 82 supported within the housing 80 to transmit the first pulse of light generated by the generation laser 24 appearing along path 84 as emitted from a coupler 86
5 which couples the optical fiber 32 to the housing 80 of the sensor head 78.

The beam splitter 82 also reflects the second pulse of light from the optical fiber 38 through a coupler 88 along a path 90 so that the resulting first
10 and second pulses of light are collinear within the sensor head 78 along a path 92 within the housing 80.

The sensor head 78 also includes a lens 94 for imaging the first and second pulses of light along a path 96 to the spots 42 and 46, respectively, on the
15 film layer of the article 30. In turn, a reflected pulse of light travels along any path within the limits set by path 96 through the lens 94, travels along any path within the limits set by path 92, is reflected by the beam splitter 82 to travel along any path within the
20 limits set by the path 90 back to the coupler 88 and back through the optical fiber 38 to the optical system 100 and to the interferometer 28 through the fiber 41.

Referring again to Figure 5, there is illustrated a schematic view of a two-fiber laser launch
25 system for the second pulse of light source. In general, the laser launch system 100 illustrates in detail how the second pulse of light is transmitted to the optical fiber 38 as well as how the reflected pulse of light is transmitted from the optical fiber 38 to the
30 optical fiber 41 and then to the interferometer 28.

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The system 100 includes a shutter 102 which allows a portion of the second pulse of light to pass therethrough along a path 104 to a focusing lens 106 which focuses the second pulse of light to a mirror or prism 107 which, in turn, directs the second pulse of light to a coupler 108 which couples the second pulse of light to the optical fiber 38.

The reflected pulse of light is transmitted by the optical fiber 38 to the coupler 108 and, after being emitted therefrom, travels along the path 110 to the condenser lens 112 for focusing to the optical fiber 41 by means of a coupler 114.

Referring now to Figure 6, there is illustrated a more complex system, generally indicated at 120, also constructed in accordance with the present invention. The generation laser 24, the detection laser 26 and the interferometer 28 of the system are located in a laser room 122 which is remote from a paint booth 124 in which a plurality of sensor heads, such as the sensor head 34, are located at a plurality of sensor stations 130.

The system 120 includes multiplexing and demultiplexing elements 126 for multiplexing or directing the first and second pulses of light generated by the generation laser 24 and the detection laser 26 into first and second pluralities of beams of light and for demultiplexing or collecting the reflected pulses of light for detection by the interferometer 28. Optical fiber bundles 128 extend between the room 122 and local controllers 129 located near the paint booth 124 adjacent their respective sensor stations 130. The fiber

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bundles 128 provide paths for the first and second plurality of beams of coherent light and the reflected pulses of light between the two areas. Each local controller 129 includes a computer for controlling multiplexing elements (not shown) for multiplexing or directing the first and second pulses of light generated by the generation laser 24 and the detection laser 26 and demultiplexers (not shown) for demultiplexing or collecting the reflected light pulses for ultimate use by the interferometer 28.

In this manner, only a few number of optical fibers need be connected between the laser room 122 and the local controllers 129 which typically will be widely separated. A larger number of optical fibers 131 which extend from the local controllers 129 to the plurality of sensor heads, such as sensor head 34, are of a much shorter length, thus reducing the total amount of optical fiber required. In systems with a few number of sensor heads, the local controller multiplexer can be omitted.

In the embodiment of Figure 6, multiplexing is utilized to take multiple measurements with the above components. Multiplexing both light sources 24 and 26 and the reflected light pulses from the car body surfaces couple the light beams into the fiber optic cables 128. The light sources 24 and 26 and the interferometer 28 are located remotely from automotive body assemblies 136.

With the use of acousto-optic (AO) cells and/or reflective optics on galvanometers and/or translating fiber optical switches (or any form of optical

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switches), pulses from the light sources 24 and 26 can be directed into a specified fiber of a large set of fibers. In conjunction with directing pulses from the light sources 24 and 26 into different fibers, the output from the fiber which collects the reflected light from the film surface is directed to the interferometer 28 for recording and processing.

The sensor heads 34 are positioned to make measurements at the desired multiple remote positions at the sensor stations 130. The second light source 26 and the light reflected from the film of the article are either carried on separate fibers or combined into a single fiber with a beam splitter or similar optic.

In this manner, the film build measurement of many different positions with the same light sources and interferometer is achieved.

As illustrated in Figures 6 and 8, the article may be an automotive assembly 136 of metal parts which moves relative to arches 142 of sensor heads 34 of the system. In such a system, position signals generated by an encoder and limit switches (not specifically shown but located within the spray booth) coupled to the moving assembly 136 through a carriage 134 and connected to the local controllers 129 are processed together with the measurements at the computer 50 to locate those areas of the film which are either too thin or too thick.

The method and system may be utilized with a robot controller 138 which controls a robot 140 to spray coat a surface of the assembly 136 at the location of

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the thin film. Another method would utilize the thickness signals as a closed loop feedback control to adjust some parameter(s) (e.g. paint flow control) of the process.

5 In the example illustrated in Figure 6, each optical fiber bundle 128 preferably includes two optical fibers to service each local controller 129. Each optical fiber bundle 131 preferably includes eighteen optical fibers to service the nine total sensor heads 34
10 positioned at each sensing station 130 within the paint booth 124.

 The computer 50 operates as a data collection and analysis device. A separate computer system controller 141 serves as a controller for controlling
15 operation of the generation laser 24, the detection laser 26, the interferometer 28, and the multiplexing and demultiplexing elements 126. The system controller 141 includes input/output circuits not only for control
20 purposes but also to allow the separate controller 141 to communicate with either the limit switches and the encoder within the spray booth directly or, preferably, with other computers of the local controllers 129 which monitor these signals.

25 The encoders within the spray booth are coupled to an assembly line 133 which, in turn, moves carriages 134 which support the automotive body assemblies 136 as illustrated in Figure 7.

 The sensors shown in Figure 7 may be fixed or
30 contain rotation components to allow the sensors to

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remain pointed approximately at the normals to the article.

The input/output circuits in the local controllers 129 allow its computer to communicate with the encoder(s) which generates a position signal representative of the position of each carriage 134. Preferably, each encoder is an optical incremental encoder mounted to a return wheel about which a chain drive of the assembly line 133 moves. The local controllers 129 know when to look at the position signals provided by their encoders through the use of their limit switches which generate signal inputs to the input/output circuits of the separate computer in the laser room when the carriages 134 holding the assemblies 136 reach predetermined positions within their sensor stations 130.

The data analysis computer 50 is coupled to a computer 137 which receives data from the data analysis computer 50 so that the computer 137 can locate a surface defect in the film on the body assembly 136. The second computer 137 communicates with the computer 50 over a data link 139 and which is located outside the room 122 to report the thickness which represents the thickness of the film or the substrate as described hereinbelow. There will be one networked data link between all the computers wherever they are located. To communicate among the computers one may install a LAN.

A signal is sent by the system controller 141 through its input/output circuits to the robot controller 138 which, in turn, generates a control signal based on location of the surface defect in the film on the assembly 136. The control signal from the robot con-

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troller 138 is used by the robot 140 which is movable to a surface coating position to further coat the surface of the layer of the assembly 136.

Referring now to Figure 7, there is illustrated a sensor head arch, generally indicated at 142, which includes a plurality of sensor heads 34 mounted on vertically and horizontally extending beams 144 along the path of the automotive assemblies 136 so that measurement readings can be taken at various spots such as spots 146 along the car body assembly 136. These sensors may be fixed as shown or contain rotation components to keep the sensor, either individually or in groups, pointed approximately normal to the article at each inspection point 146.

Referring now to Figure 8, there is illustrated a top plan view of a plurality of sensor arches such as the sensor arch 142 through which automotive car body assemblies 136 travel within a paint spray booth 148. The laser room 122 contains the generation laser 24, the detection laser 26, the interferometer 28, the multiplexing/demultiplexing elements 126, the computer 50, and the separate computerized system controller 141. Optical fiber bundles 128 transmit multiplexed laser light signals therethrough to either various local controllers 129 and then on to the sensor stations 130 in the booth 148 or directly to the sensor stations 130 themselves.

Referring now to Figure 11, there is illustrated a set of graphs, each one of which is similar to the graph of Figure 10 and which illustrate how the

-24-

resonant paint frequencies change with varying wet paint thickness.

Figure 12 is a graph illustrating how a curve has been generated from LU measured values of wet white solvent base coat which calibration curve may be stored within the computer 50 for data analysis. Preferably, the data analysis computer 50 passes the resonant frequency signal of Figure 10, along with previous measurements made on the film or substrate and hence stored in the computer 50, into a model also stored in the computer 50 to determine film build of the film or the substrate on the assembly 136 as described in greater detail hereinbelow.

Summary of Data Analysis

In brief, there are three main components to the data analysis of the method and system of the present invention: signal processing; signal modeling; and wet-film to cured-film prediction.

For the particular case of laser-based ultrasonics, the method and system operate in accordance with the block diagram flow chart of Figure 13.

The flow chart of Figure 13 is an example of the process involved in a wet paint measurement. Briefly, the programmed computers 50 and 137 transform the raw ultrasound signals or data at block 182 from the interferometer 28 into amplitudes, frequencies, and decay rates after processing at block 184. The frequencies measured are used in a model (physical model or

-25-

calibration model) to yield a thickness measurement as indicated at block 186.

5 In the case of automotive coatings, one assumes the measurement of multiple plane-layered systems. The layers can be described as:

- Substrate layer: usually steel, aluminum, plastic, or composite
 - Static film layer: usually cured paint, primer, e-coat, clearcoat, phosphate
 - 10 • Dynamic film layer: usually wet or dehydrated paint, primer, clearcoat, e-coat, etc. Thickness and other physical properties, changing with time.
- 15

The method and system can be utilized to measure static and dynamic films.

20 There are several methods by which one can convert frequency to thickness. One can use empirical calibration to convert frequency to dried film thickness. The main disadvantages to calibrating dynamic films are the inclusion of extra variables. Some of these would be:

- 25 • elapsed time of measurement from time of spray
- temperature
- humidity
- preparation of paint
- atomization pressure
- 30 • fan patterning
- paint composition

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These effects may be impossible to quantify accurately.

In essence, a film loses base material via evaporation. The method and system of the present invention measure the amount of base and the amount of solids at the instant of measurement. The method and system have no need to include any of the aforementioned environmental variables that affect the wet film.

Signal Processing of Block 184

The invention models ultrasound as the summation of M decaying sinusoids. The modeling process is: find frequencies and decay rates from raw data; and perform harmonic analysis of raw data using these results.

Find Frequencies and Decay Rates From Raw Data

One measures frequencies and decay rates from raw ultrasound data or signals by pole-zero modeling. Specifically, the ultrasound signals one receives can be modeled as exponentially decaying sinusoids. This problem was first solved by Prony in 1795, and the basic mathematics are substantially identical to what one uses today. Only the computation of the math is modernized. Basically, a decaying complex sinusoid forms a pole in the Z-transform domain. However, only frequency and decay rate information are contained in that pole as discussed by Oppenheim and Schafer in their book "Discrete-Time Signal Processing", Prentice Hall, 1989:

$$y(n) = Ae^{(-\alpha + j2\pi f)n}u[n] \Leftrightarrow A(1 - e^{(-\alpha + j2\pi f)z^{-1}})^{-1}$$

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where A is the amplitude of the signal, α is the decay rate, f is frequency, and n is the discrete-time index.

By converting the problem of finding poles to a problem of finding zeros, the algorithm becomes:

5 Least-squares fit a linear prediction filter to the poles from raw data, i.e. transform signal to z-domain.

Find the zeros of the above filter in the z-domain.

10 Convert zeros to frequencies and decay rates.

Where:

L = size (order) of filter;

M = number of decaying sinusoidal signals in the raw data-in general $M < L$; and

15 N = number of raw data points to transform.

a. *Least Squares Fit A Linear Prediction Filter to the Poles From Raw Data*

From Prony's method, one solves the following equations to find the filter:

$$A = \begin{bmatrix} y^*(1) & y^*(2) & \dots & y^*(L) \\ y^*(2) & y^*(3) & \dots & y^*(L+1) \\ \vdots & \vdots & \ddots & \vdots \\ y^*(N-L) & y^*(N-L+1) & \dots & y^*(N-1) \end{bmatrix}$$

$$b = [b(1), b(2), \dots, b(L)]^T$$

20 A b=h

-28-

$$h = [-y^*(0), -y^*(1), \dots, -y^*(N-L-1)]^T$$

L = size of filter

N = number of raw data points to transform

y^* is the complex conjugate of the data.

The above equation is very difficult to solve not only because of noisiness in y , but also because $L > M$. Essentially, two (or more) rows in the matrix can become equal and cause a zero to appear in a denominator

5 - one says that the problem is poorly conditioned or ill-conditioned.

In laser ultrasonics of the present invention, the SNR ranges approximately from 0 to 40 dB, i.e. low to moderate SNR. More importantly, the number of

10 sinusoids dynamically changes with the film layer system being measured. Therefore, one needs a robust method to extract the filter from the noisy data.

The SVD, or Singular Value Decomposition method, works quite well on the above equations given

15 the data laser ultrasound produces. The SVD method, as applied to the decaying sinusoid problem, was first described by Kumaresan and Tufts in 1983 and is often called the KT method.

Basically, one solves the filter equation

20 using SVD. With SVD, one can use a filter whose order is larger than the number of signals one expects to receive. Increasing the filter size causes A to become singular. An intermediate solution then truncates the final solution to approximate the number of signals.

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This improves the accuracy of the fit to the pole locations.

Presently, however, there is no need to truncate the SVD to obtain desired results for frequency precision. Truncation often destroyed the detectability of important signals (like low amplitude metal signals). Instead, "important" or desired signals are identified by amplitudes and knowledge of the film layer system.

b. Find The Poles of the Filter

The zeros of $B(x)$ contain M signal zeros and $L-M$ extraneous (or noise) zeros. The frequency/decay rate information is extracted by rooting the filter polynomial $B(x)$. For example, consider a one-signal system:

$$B(x) = 1 - e^{(-\alpha + j2\pi f)x} x = 0 \Leftrightarrow x = e^{(-\alpha + j2\pi f)}$$

$B(z)$ is changed to $B(x)$ to emphasize that the problem is changed from finding poles to finding zeros. Secondly, the signal zeros will have positive decay rates (for exponentially damped signals) while the noise zeros will have negative decay rates. This is because noise level is theoretically constant (i.e. non-decaying). Finally, for zero decay signals, noise can "push" the measured decay rate to a negative value.

Because of the fairly large order of polynomial, one needs a very robust method of extracting the poles from the filter. Iterative methods are slow and generally fail for large polynomials. An eigenvalue method is used to perform this calculation.

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To find eigenvalues of a matrix, one performs the operation:

$$\det [W-xI] = 0$$

where $\det[]$ is the determinant of the matrix $W-xI$. The problem is set up using the filter coefficients from $B(x)$ in a companion matrix:

$$B(x) = \det [W-xI] = \sum_{i=0}^L b(i)x^i = 0$$

$$W = \begin{bmatrix} -\frac{b(L-1)}{b(L)} & -\frac{b(L-2)}{b(L)} & \dots & -\frac{b(1)}{b(L)} & -\frac{b(0)}{b(L)} \\ 1 & 0 & \dots & 0 & 0 \\ 0 & 1 & \dots & 0 & 0 \\ \vdots & \vdots & & \vdots & \vdots \\ 0 & 0 & \dots & 1 & 0 \end{bmatrix}$$

Then, one can use basically the same theory (and mathematics) involved in SVD to find the eigenvalues of the new matrix. Specifically, a QR method is used to estimate the eigenvalues. Specifics of how to compute the QR decomposition are well known.

c. Convert From Roots To Frequencies And Decay Rates

The signal zeros are sorted from the noise zeros by ignoring all $|z| < c$ where for now $c = 1.000000$. This value may be changed to a number like 0.980000 because sometimes the metal peaks' signal zeros are pushed inside $|z| < 1$ by noise (these generally lie at about 0.9995 or 0.995).

To determine frequency f and decay α , one uses the following:

$$f = \text{atan}(z_i/z_r) / 2\pi$$

$$\alpha = -\log(|z|)$$

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Perform Harmonic Analysis of Block 184

In order to obtain amplitudes, one simply performs a harmonic data analysis using the frequencies and decay rates obtained above. Essentially, one
 5 performs a general linear least squares fit to the raw data:

$$K = \begin{bmatrix} \exp(s_1 0) & \exp(s_2 0) & \dots & \exp(s_L 0) \\ \exp(s_1 1) & \exp(s_2 1) & \dots & \exp(s_L 1) \\ \vdots & \vdots & & \vdots \\ \exp(s_1 (N-1)) & \exp(s_2 (N-1)) & \dots & \exp(s_L (N-1)) \end{bmatrix}$$

$$Ka = y$$

$$a = [a_1, a_2, \dots, a_L]^T$$

$$y = [y(0), y(1), \dots, y(N-1)]^T.$$

These equations are not ill-conditioned and are thus easy to solve by general linear least squares. Specifically, a simple Gauss-Jordan technique is used to
 10 invert K. This technique is also very well known and specifics of computation will not be discussed further.

Signal Modeling of Block 186

Modeling of the propagation of ultrasound in
 15 the layers is important to any non-calibrating measurement, as described herein. The system is modeled as a compressional wave traversing through plane layers.

Given enough information (i.e. from block 188) and enough signal (i.e. from block 184), one can find
 20 (true) wet thickness. Additionally, one can find speed of sound, density, and possibly viscosity and attenua-

-32-

tion. The acoustic impedance of a material is the product of speed of sound and density:

$$Z = \rho c$$

Acoustic impedance controls how a wave is transmitted/reflected at a boundary (i.e. free, rigid, or other reflection) and how the "paint" frequencies interact with "metal" frequencies (and vice versa). Thickness and speed of sound determine how quickly the wave propagates through a layer. Attenuation describes how much energy the wave loses (to heat or other) as it propagates through the layer. Given the model of block 186, as well as good data from block 184, one can solve for any of speed of sound, thickness, density, and/or attenuation using optimization techniques.

The resonance frequency model of block 186 is used to obtain thickness, speed of sound, and density information. Consider a lossless single layer film on a lossless steel substrate. The model for frequency resonance for this particular system is:

$$Z_p \tan \left(2\pi f \frac{d_p}{c_p} \right) + Z_s \tan \left(2\pi f \frac{d_s}{c_s} \right) = 0 = Q(d, c, \rho, f)$$

where f is any resonant frequency (paint or metal), d is thickness, c is speed of sound, subscript p refers to paint layer qualities, and subscript s refers to steel substrate qualities.

This equation can be solved numerically. Specifically, one minimizes $Q(d, c, \rho, f)$ for desired variables/parameters/data. However, there are many ways to perform the minimization. For example, since one

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knows the various properties of the steel, one minimizes the following:

$$\frac{Z_p}{Z_s} \tan \left(2\pi f_i \frac{d_p}{c_p} \right) + \tan \left(2\pi f_i \frac{d_s}{c_s} \right) = Q \left(f_i; z_p, \frac{d_p}{c_p} \right) / Z_s$$

$$\text{Min}_{\text{simplex}} \left\| \sum_i Q^2 \left(f_i; z_p, \frac{d_p}{c_p} \right) / Z_s^2 \right\| \Rightarrow z_{\text{opt}}, (d/c)_{\text{opt}}$$

where $i = 1, 2, \dots$ number of measured resonances. The ; symbol represents that z and d/c are parameters to be optimized while f_i is input data. The minimization is performed using the well known simplex method, and will not be discussed in detail here.

Wet Prediction

The process to predict a cured film thickness from a wet film thickness is a two-step process: Perform wet to uncured prediction of block 192;

- estimate wet to uncured prediction factor from data of block 190;
- calculate uncured thickness; and

Perform uncured to baked or cured prediction of block 194.

Perform Wet to Uncured Prediction (Block 192)

Estimate Wet to Uncured Prediction Factor Via Laser-Based Ultrasound (Block 190)

Solving for the quantities such as z and d/c in the wet layer is important. For the particular case of ultrasonic measurement, one measures impedance and one-way transit time of the wet layer - call them z_{wet} (d/c)_{wet}, respectively. Density and speed of sound vary

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with particulate size and particulate concentration, as well as solvent properties. If one can measure impedance, one can then estimate percent solids or particulate concentration - call percent solids R_{wet} (let R_{wet} be a pure ratio less than 1 and not a percent). Symbolically, one measures R_{wet} (or $(Rv)_{\text{wet}}$) from Z_{wet} as:

$$R_{\text{wet}} V_{\text{wet}} = (Rv)_{\text{wet}} = f(Z_{\text{wet}}).$$

One can also use this data to measure d_{wet} .

The functionality of $f()$ is either derived or measured, depending on application, knowledge available, etc. Note that it is very possible to measure $f()$ using results from other techniques, say Time Resolved Infra-red radiometry (TRIR), as well as using this same process for wet prediction. See the next section for details.

Calculate Uncured Thickness (Block 192)

Once R_{wet} and d_{wet} (or even $(Rv)_{\text{wet}}$ and $(d/v)_{\text{wet}}$ for the special case of this laser ultrasonic application) are estimated, one is ready to perform wet prediction. The following wet film to dry film thickness prediction conversion is independent of measurement method.

Percent solids or particulate concentration tells what the wet layer will reduce to if all of the solvent is removed. The predictive thickness of the uncured but base-free paint is called d_{uncured} . Mathematically, this is expressed as:

$$d_{\text{uncured}} = R_{\text{wet}} d_{\text{wet}}$$

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or

$$d_{\text{uncured}} = (Rv)_{\text{wet}} (d/v)_{\text{wet}}.$$

As an example, if one measures 4 mils thick wet water-based ($d_{\text{wet}}=4.00$ mil) at 75% solids ($=R_{\text{wet}}=0.75$), that means the wet layer will reduce to 3 mils ($=d_{\text{uncured}}=R_{\text{wet}}d_{\text{wet}}=0.75 \times 4.00 \text{ mil} = 3.00 \text{ mil}$).

Perform Uncured to Baked (i.e. Cured) Prediction (Block 194)

One must also know how the uncured wet layer chemically reacts to become "paint". However, there is basically no way to predict how wet paint chemically reacts via ultrasound, thermal, image interferometry, microwave, millimeter wave, capacitance, etc., unless the reaction itself is monitored.

One measures the prediction in a laboratory or through knowledge of the chemical reaction. One method used with the present invention is to measure the prediction using density, as indicated at block 196. The density of cured paint will be measured - call it ρ_{cured} . The density of uncured (and solvent- or water-free) paint will be measured - call it ρ_{uncured} . Because the paint has been applied to a surface, the area of the uncured and cured paint is constant. Therefore, the uncured to cured paint prediction is:

$$d_{\text{cured}} \rho_{\text{cured}} = d_{\text{uncured}} \rho_{\text{uncured}}.$$

One can then predict the final, baked or cured thickness, as indicated at block 198.

It is possible that the above method can be used to measure wet glue to dry glue thickness, as well

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as other properties of the glue. Molten coatings, certain composites, etc. would also be measurable with the method and system of the present invention.

Wet Film Prediction and Measurement

5 **Determination of the Functionality of R_{wet}**

There are several ways to determine the functionality of R_{wet} . First is to use theory of the basic measurement technique. For example, one could incorporate particle size, particle composition, particle concentration, base composition, particle-base interaction, frequency, etc. into a physical model for $f()$.

Another method to determine the functionality of $R_{wet} = f()$ for a given paint is calibration. As an example, consider measurement of $R_{wet} = f(c_{wet})$ for black solvent-based paint. One can prepare many samples of paint with various R_{wet} and measure the corresponding c_{wet} . Then a curve can be fit in order to determine $R_{wet} = f(c_{wet})$.

20 While the best mode for carrying out the invention has been described in detail, those familiar with the art to which this invention relates will recognize various alternative designs and embodiments for practicing the invention as defined by the following
25 claims.

What Is Claimed Is:

1. In a measurement system wherein time-varying physical signals containing frequency information related to a physical parameter of an object are measured to obtain corresponding time-varying measurement signals, a method for processing the measurement signals to obtain a value for the physical parameter, the method comprising the steps of:
 - extracting the frequency information from the measurement signals, the frequency information including at least one desired frequency; and
 - converting the frequency information to a value for the physical parameter.
2. The method as claimed in claim 1 wherein the frequency information includes a decay rate and an amplitude for the at least one desired frequency.
3. The method as claimed in claim 1 wherein the object is a static film.
4. The method as claimed in claim 3 wherein the static film is a cured layer formed on a substrate.
5. The method as claimed in claim 4 wherein the physical parameter is thickness of the layer.
6. The method as claimed in claim 1 wherein the object is a dynamic film having a physical parameter which changes in value over time.

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7. The method as claimed in claim 6 wherein the dynamic film is a wet or dehydrated layer formed on a substrate.

8. The method as claimed in claim 7 wherein
5 the physical parameter is thickness of the layer.

9. The method as claimed in claim 1 wherein the physical signals are electromagnetic signals.

10. The method as claimed in claim 9 wherein the electromagnetic signals are light signals.

10 11. The method as claimed in claim 10 wherein the light signals are coherent light signals.

12. The method as claimed in claim 11 wherein the coherent light signals are modulated coherent light signals and wherein the modulated coherent light signals
15 are modulated based on the frequency information.

13. The method as claimed in claim 1 wherein the physical parameter changes in value over time from an initial value to a final value and wherein the step of converting includes the step of predicting the final
20 value from the initial value.

14. The method as claimed in claim 13 wherein the physical parameter changes in value over time from the initial value to an intermediate value and then to the final value and wherein the step of predicting includes the step of first predicting the intermediate
25 value from the initial value and then predicting the final value from the intermediate value.

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15. The method as claimed in claim 14 wherein the object is a curable film and the physical parameter is film thickness and wherein the initial value is wet film thickness, the intermediate value is uncured film thickness and the final value is cured film thickness.

16. The method as claimed in claim 13 wherein the frequency information is related to propagation of waves in the object and wherein the step of predicting includes the step of processing the frequency information with a model of the propagation of the waves in the object.

17. The method as claimed in claim 1 wherein the measurement signals are discrete time signals and wherein the step of extracting includes the step of transforming the discrete-time signals to a Z-domain and wherein the frequency information is contained in at least one zero or pole in the Z-domain.

18. The method as claimed in claim 17 wherein the frequency information includes an amplitude and a decay rate for the at least one frequency and wherein the step of extracting further includes the step of converting the at least one zero or pole in the Z-domain to the at least one frequency and its amplitude and decay rate.

19. The method as claimed in claim 1 wherein the measurement signals are ultrasonic signals and wherein the frequency information is related to propagation of ultrasonic waves in the object.

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20. The method as claimed in claim 19 wherein the ultrasonic waves are longitudinal ultrasonic waves.

21. In a measurement system wherein time-varying physical signals containing frequency information related to a physical parameter of an object are measured to obtain corresponding time-varying measurement signals, a system for processing the measurement signals to obtain a value for the physical parameter, the system comprising:

10 means for extracting the frequency information from the measurement signals, the frequency information including at least one desired frequency; and

means for converting the frequency information to a value for the physical parameter.

15 22. The system as claimed in claim 21 wherein the frequency information includes a decay rate and an amplitude for the at least one desired frequency.

23. The system as claimed in claim 21 wherein the object is a static film.

20 24. The system as claimed in claim 23 wherein the static film is a cured layer formed on a substrate.

25. The system as claimed in claim 24 wherein the physical parameter is thickness of the layer.

25 26. The system as claimed in claim 21 wherein the object is a dynamic film having a physical parameter which changes in value over time.

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27. The system as claimed in claim 26 wherein the dynamic film is a wet or dehydrated layer formed on a substrate.

28. The system as claimed in claim 27 wherein
5 the physical parameter is thickness of the layer.

29. The system as claimed in claim 21 wherein the physical signals are electromagnetic signals.

30. The system as claimed in claim 29 wherein the electromagnetic signals are light signals.

10 31. The system as claimed in claim 30 wherein the light signals are coherent light signals.

32. The system as claimed in claim 31 wherein the coherent light signals are modulated coherent light signals and wherein the modulated coherent light signals
15 are modulated based on the frequency information.

33. The system as claimed in claim 21 wherein the physical parameter changes in value over time from an initial value to a final value and wherein the means for converting includes means for predicting the final
20 value from the initial value.

34. The system as claimed in claim 33 wherein the physical parameter changes in value over time from the initial value to an intermediate value and then to the final value and wherein the means for predicting includes means for first predicting the intermediate value
25 from the initial value and means for predicting the final value from the intermediate value.

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35. The system as claimed in claim 34 wherein the object is a curable film and the physical parameter is film thickness and wherein the initial value is wet film thickness, the intermediate value is uncured film thickness and the final value is cured film thickness.

36. The system as claimed in claim 33 wherein the frequency information is related to propagation of waves in the object and wherein the means for predicting includes means for processing the frequency information with a model of the propagation of the waves in the object.

37. The system as claimed in claim 21 wherein the measurement signals are discrete time signals and wherein the means for extracting includes means for transforming the discrete-time signals to a Z-domain and wherein the frequency information is contained in at least one zero or pole in the Z-domain.

38. The system as claimed in claim 37 wherein the frequency information includes an amplitude and a decay rate for the at least one frequency and wherein the means for extracting further includes means for converting the at least one zero or pole in the Z-domain to the at least one frequency and its amplitude and decay rate.

39. The system as claimed in claim 21 wherein the measurement signals are digitized ultrasonic electrical signals and wherein the frequency information is related to propagation of ultrasonic waves in the object.

-43-

40. The system as claimed in claim 39 wherein the ultrasonic waves are longitudinal ultrasonic waves.

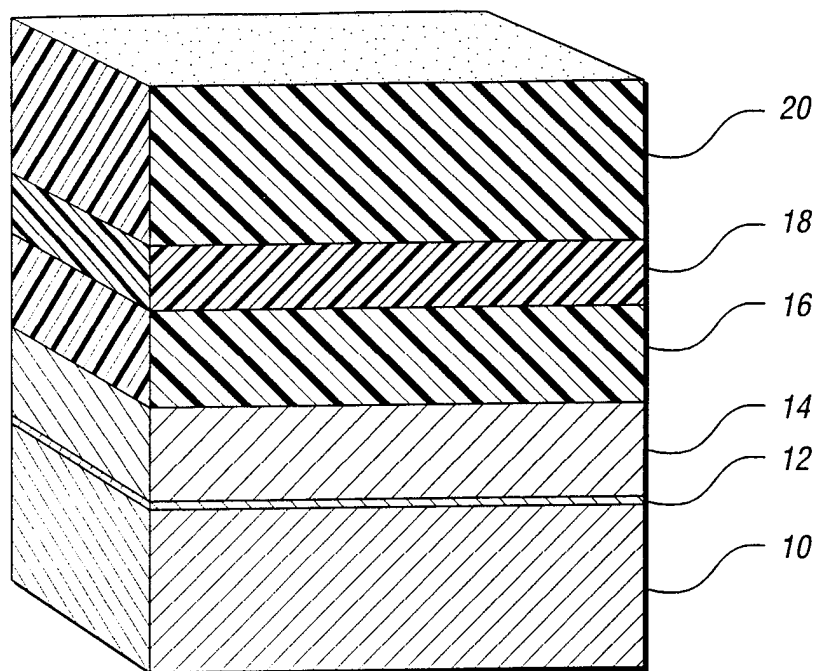


Fig. 1

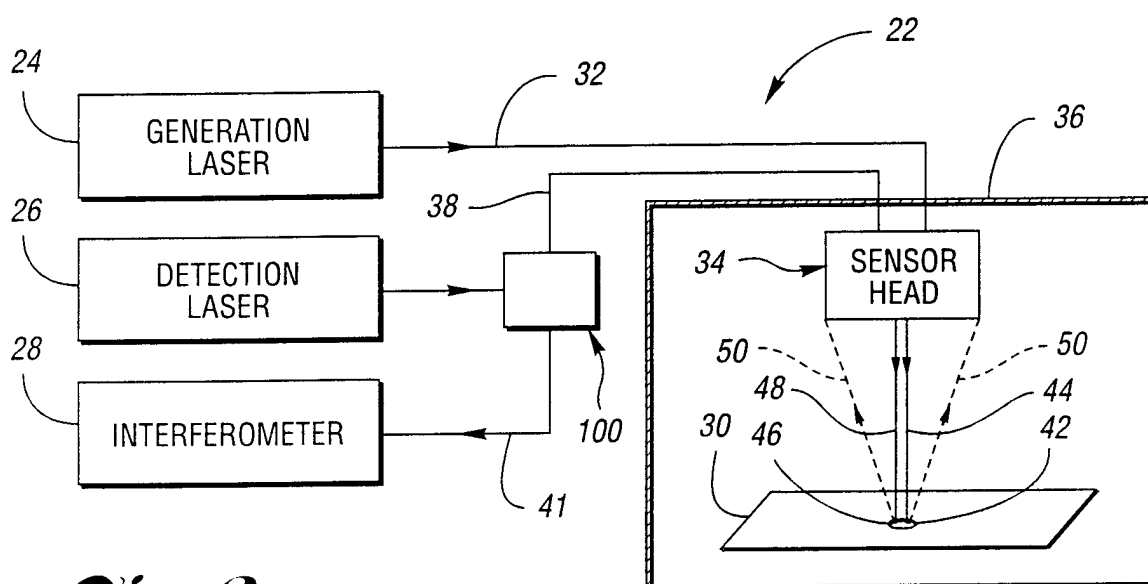


Fig. 2

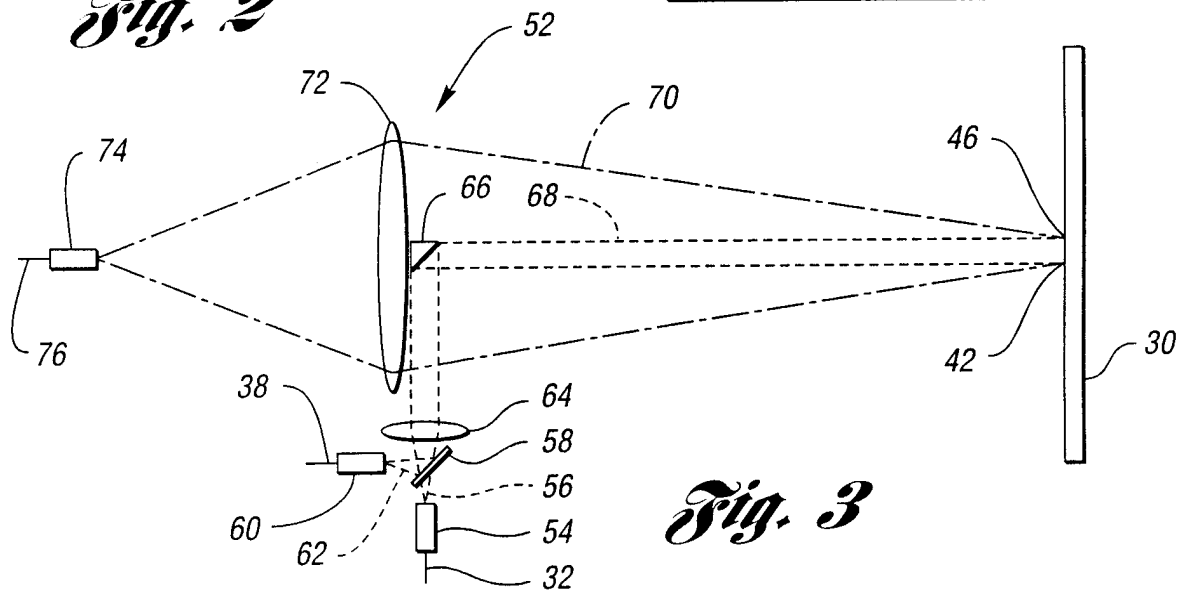


Fig. 3

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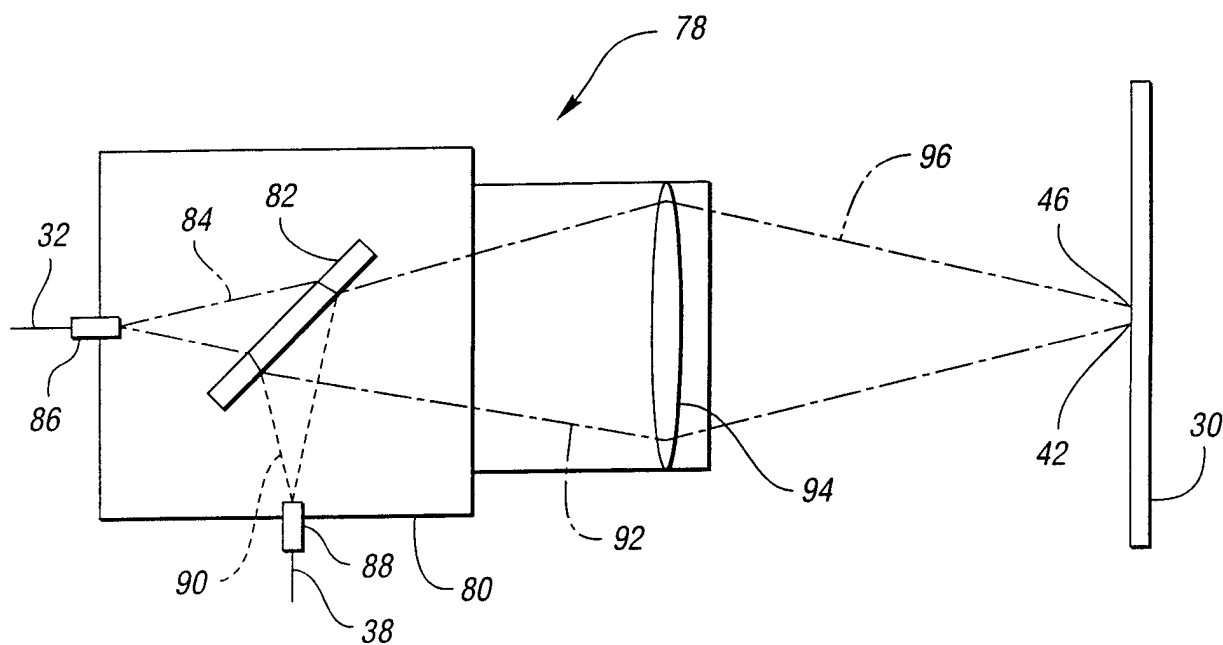


Fig. 4

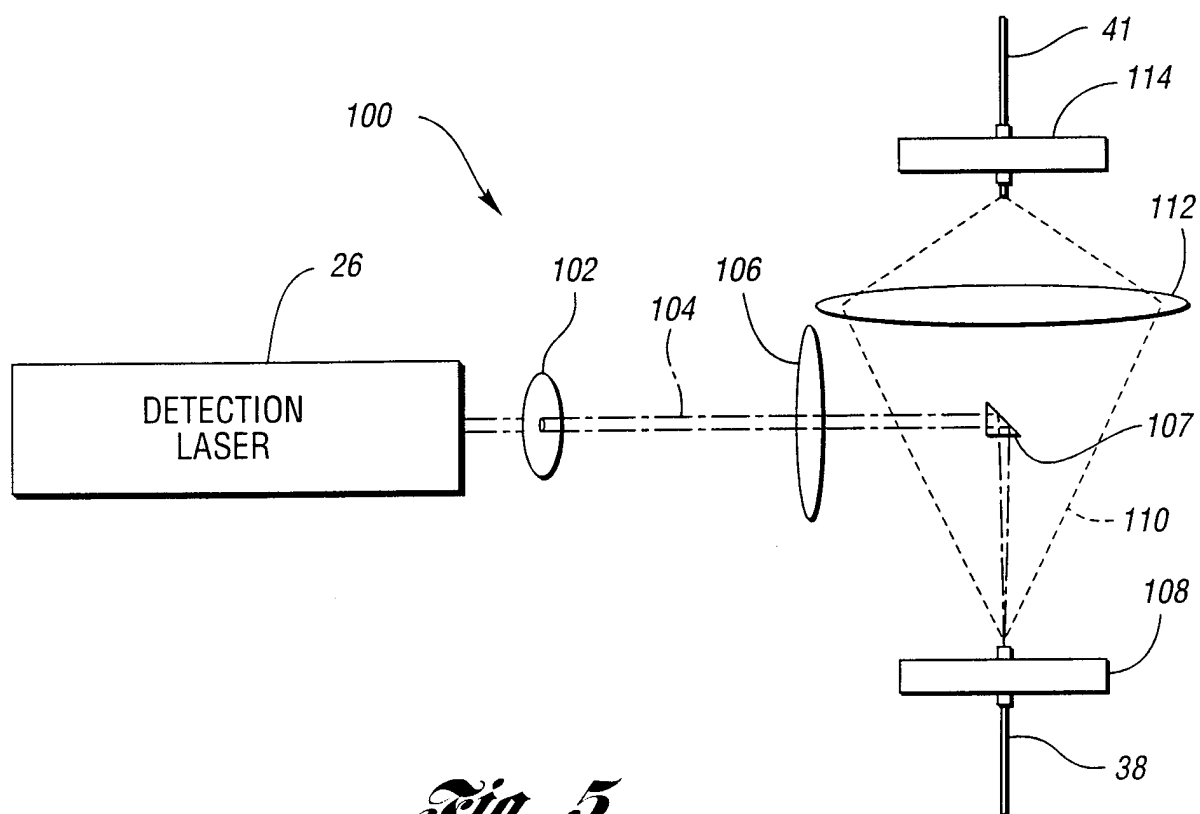


Fig. 5

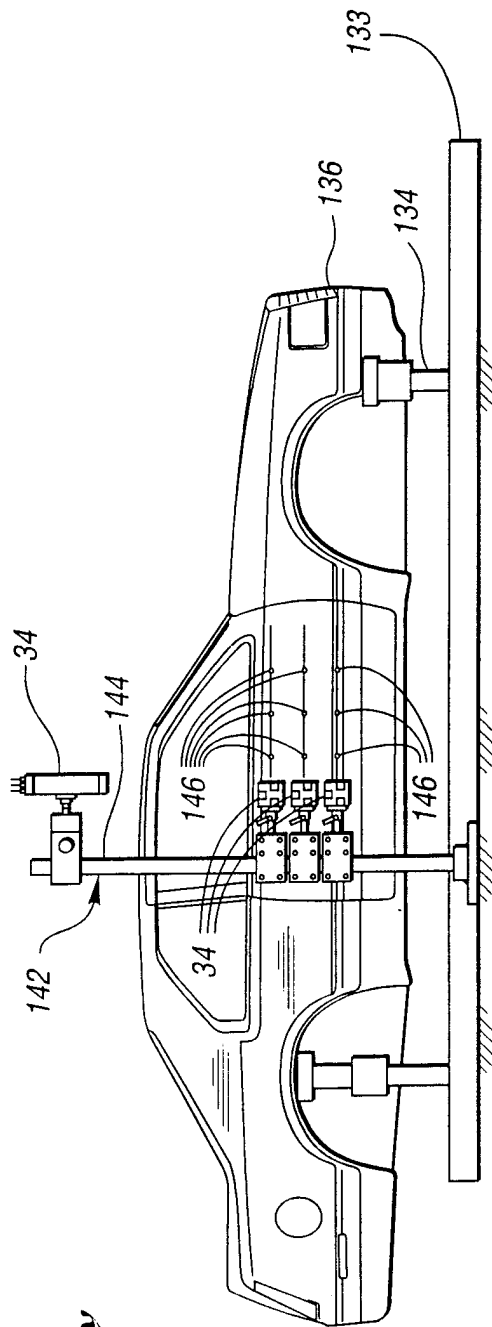
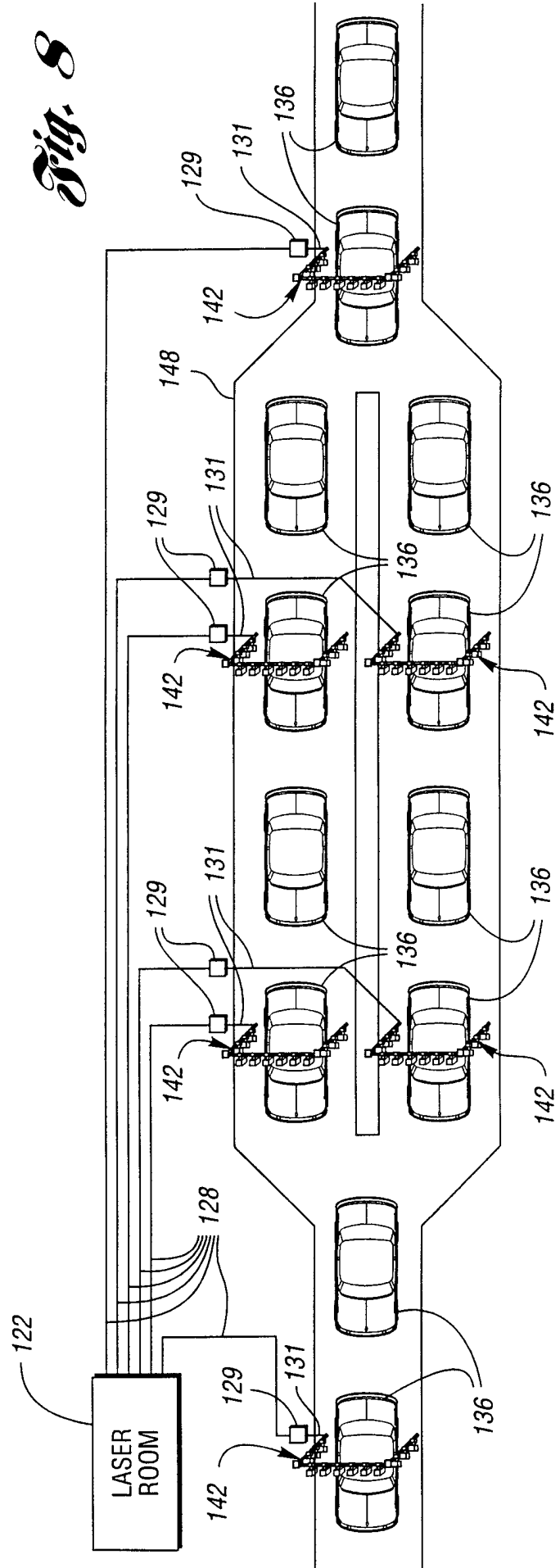
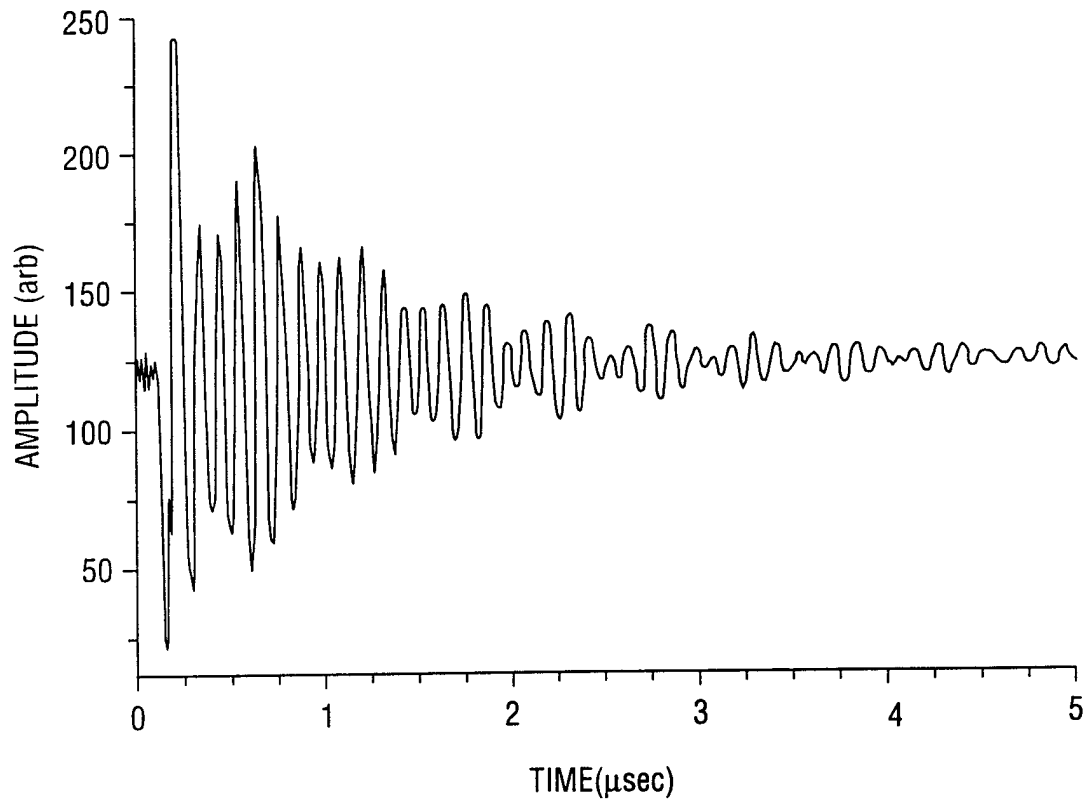
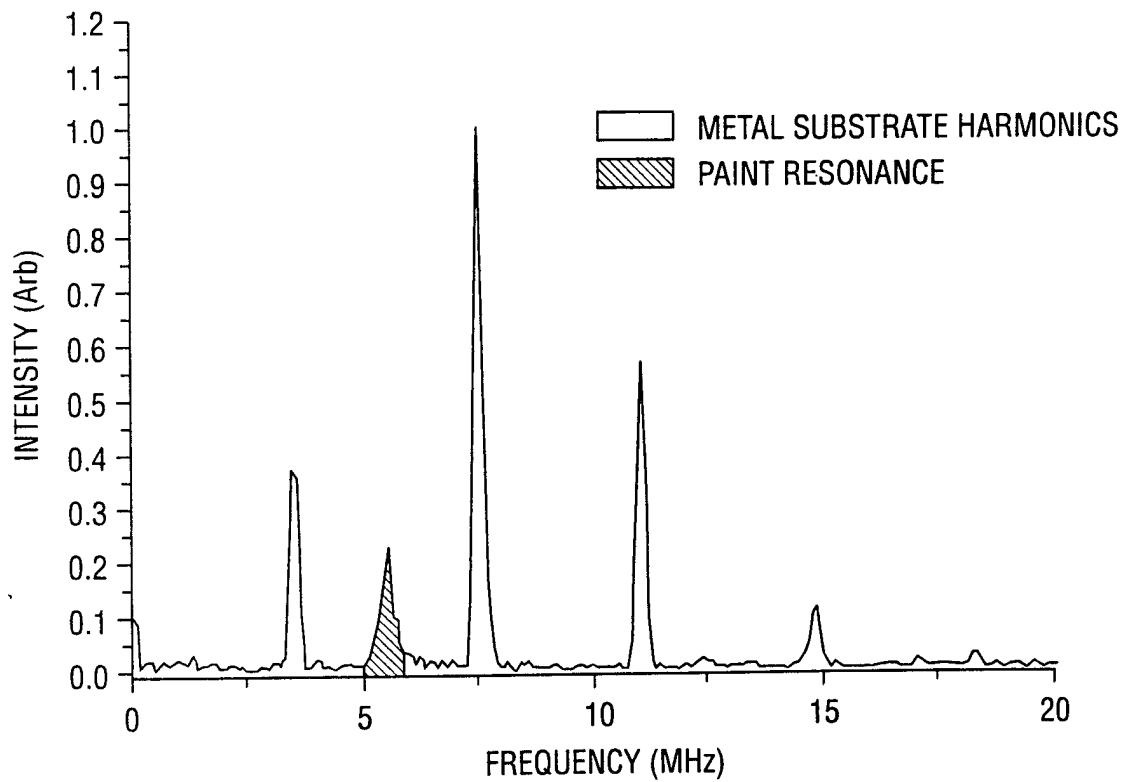


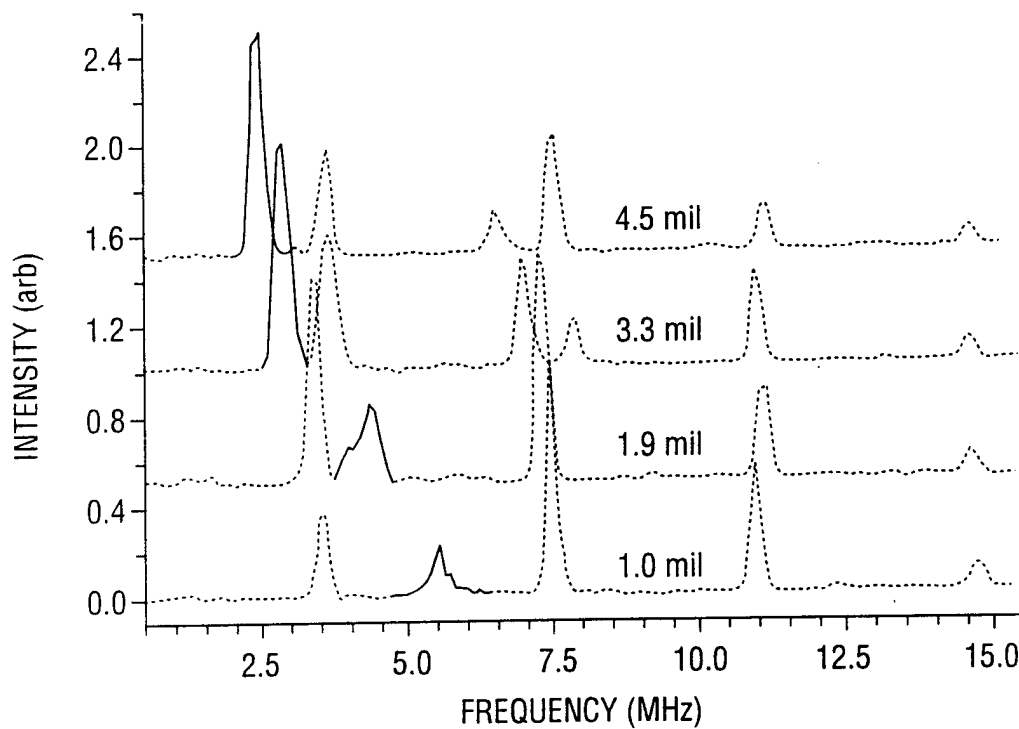
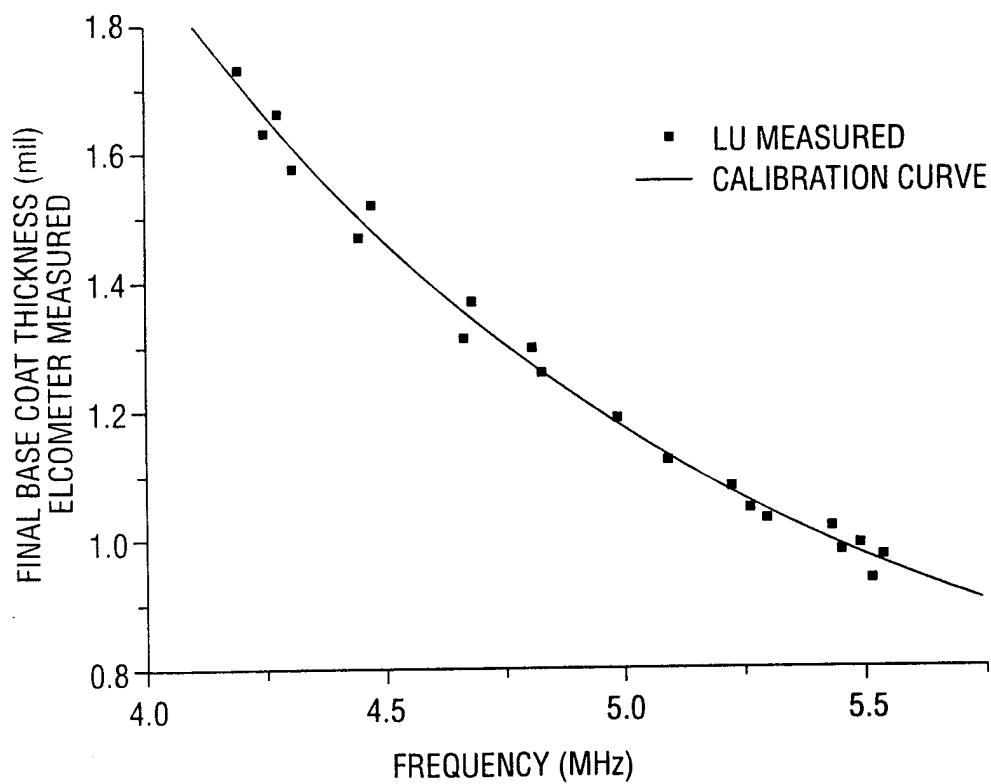
Fig. 8



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*Fig. 9**Fig. 10*

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*Fig. 11**Fig. 12*

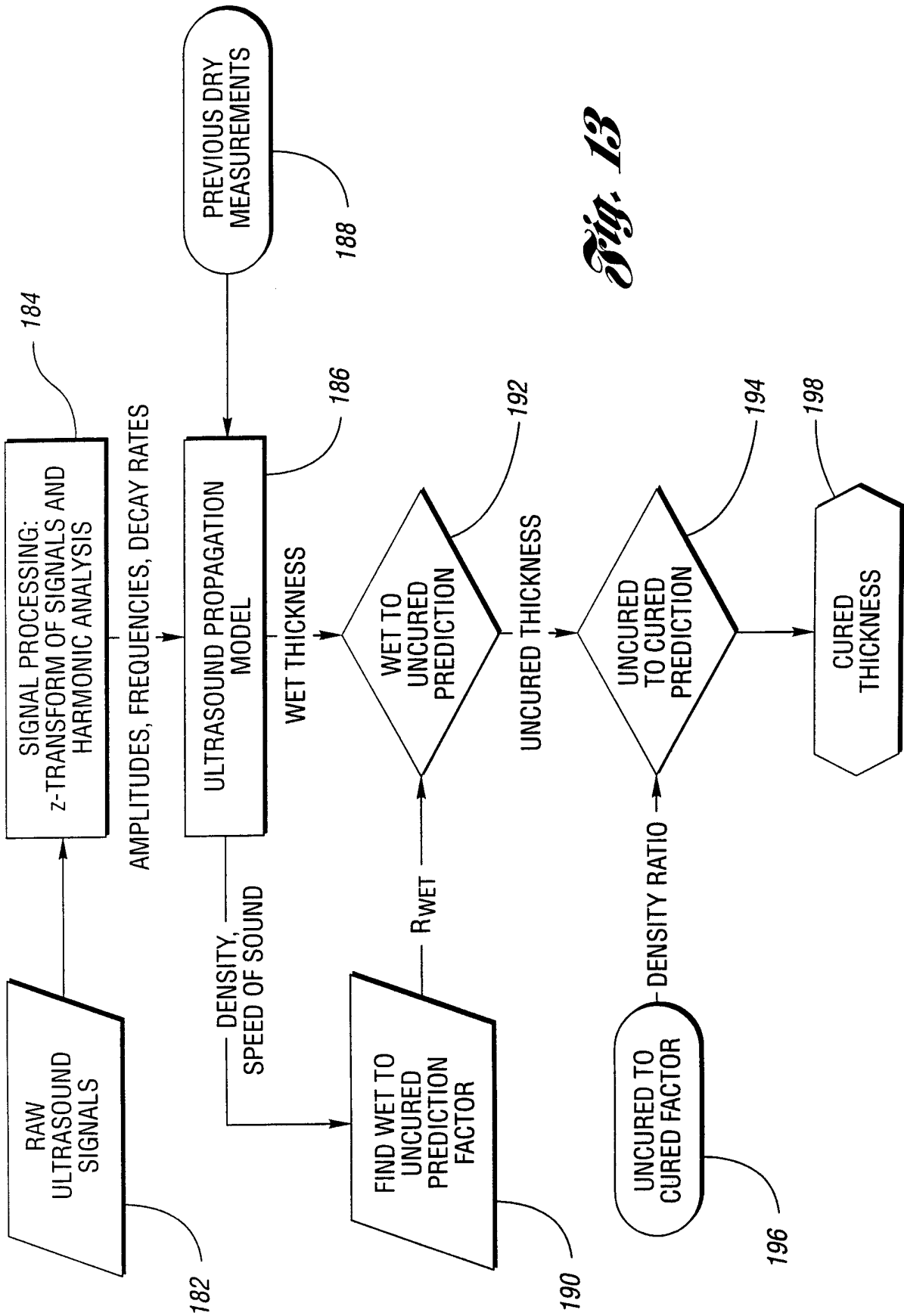


Fig. 13

INTERNATIONAL SEARCH REPORT

International application No.
PCT/US97/21308

A. CLASSIFICATION OF SUBJECT MATTER

IPC(6) : G01N 29/08, 29/10

US CL : 73/579, 602; 364/507; 250/231 R

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 73/579, 596, 597, 598, 599, 602, 653, 657; 364/507; 250/231 R; 356/381, 382, 355, 357, 345

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

APS: decay rate, frequency, fft, fourier transform, amplitude, z domain

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X --- A	US 3,580,056 A (WARNER) 25 May 1971 (25.05.71), see abstract, Figures, column 1 lines 60-70	1, 2, 21, 22 ----- 17-18, 37-38
X	US 4,379,226 A (SICHLING ET AL.) 5 April 1983 (05.04.83) see abstract, Figures, column 2 line 20 - column 3 line 21	1, 9-12, 21, 29-32
X	US 4,452,082 A (MIWA) 5 June 1984 (05.06.84) see abstract, Figures, column 1 line 65 - column 2 line 47, column 3 lines 10-30.	1-2, 19, 21-22, 39
X	US 4,625,556 A (SUKAHARA ET AL.) 02 December 1986 (02.12.86), see abstract, Figures, column 1 line 61 - column 2 line 40.	1, 3-5, 19-21, 23-25, 39-40

☒ Further documents are listed in the continuation of Box C. ☐ See patent family annex.

* Special categories of cited documents:	*T* later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
A document defining the general state of the art which is not considered to be of particular relevance	*X* document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
E earlier document published on or after the international filing date	*Y* document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
L document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)	*Z* document member of the same patent family
O document referring to an oral disclosure, use, exhibition or other means	
P document published prior to the international filing date but later than the priority date claimed	

Date of the actual completion of the international search

11 FEBRUARY 1998

Date of mailing of the international search report

06 APR 1998

Name and mailing address of the ISA/US
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INTERNATIONAL SEARCH REPORT

International application No.
PCT/US97/21308

C (Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 4,704,905 A (ARORA) 10 November 1987 (10.11.87), see abstract, Figures, column 3 lines 19-45	1-2,17-22, 37-40
X	US 4,709,357 A (MAKI, JR.) 24 November 1987 (24.11.87), see abstract, Figures, column 4 line 63 -column 6 line 6.	1-2, 17-18, 21-22, 37-38
X --- A	US 5,271,274 A (KHURI-YAKUB ET AL.) 21 December 1993 (21.12.93), see abstract, Figures, column 2 lines 42-62, column 3 lines 3-15 and 40-49, column 4 lines 19-61.	1, 6-11, 19-21, 26-31, 39-40 ----- 13-16, 33-36
X,P	US 5,663,502 A (NAGASHIMA ET AL.) 2 September 1997 (02.09.97), see abstract, Figures, column 2 line 20 - column 3 line 50.	1, 3, 6, 19-21, 23, 26, 39-401,

INTERNATIONAL SEARCH REPORT

International application No.
PCT/US97/21308

Box I Observations where certain claims were found unsearchable (Continuation of item 1 of first sheet)

This international report has not been established in respect of certain claims under Article 17(2)(a) for the following reasons:

1. ☐ Claims Nos.:
because they relate to subject matter not required to be searched by this Authority, namely:

2. ☐ Claims Nos.:
because they relate to parts of the international application that do not comply with the prescribed requirements to such an extent that no meaningful international search can be carried out, specifically:

3. ☐ Claims Nos.:
because they are dependent claims and are not drafted in accordance with the second and third sentences of Rule 6.4(a).

Box II Observations where unity of invention is lacking (Continuation of item 2 of first sheet)

This International Searching Authority found multiple inventions in this international application, as follows:

1. ☒ As all required additional search fees were timely paid by the applicant, this international search report covers all searchable claims.
2. ☐ As all searchable claims could be searched without effort justifying an additional fee, this Authority did not invite payment of any additional fee.
3. ☐ As only some of the required additional search fees were timely paid by the applicant, this international search report covers only those claims for which fees were paid, specifically claims Nos.:

4. ☐ No required additional search fees were timely paid by the applicant. Consequently, this international search report is restricted to the invention first mentioned in the claims; it is covered by claims Nos.:

Remark on Protest

- ☐ The additional search fees were accompanied by the applicant's protest.
☐ No protest accompanied the payment of additional search fees.